Ref #	Hits	Search Query	DBs	Default Operat or	Plura Is	Time Stamp
L8	11	7 and ((silicon adj	US-PGPU	OR	ON	2005/09/23
		carbide) Sic)	В;			17:58
			USPAT;			
			EPO;			
			JPO;			
			DERWEN			
			Т;			
			IBM_TDB			

				 	T	
L7	40	(US-20010026956-\$ or US-20020016085-\$ or US-20020108929-\$ or US-20030024902-\$ or US-20030045101-\$ or US-20030162407-\$).did. or (US-5021121-\$ or US-5269879-\$ or US-6074959-\$ or US-6090304-\$ or US-6117786-\$ or US-6117786-\$ or US-6207577-\$ or US-6207577-\$ or US-6211092-\$ or US-6251770-\$ or US-6251770-\$ or US-6284149-\$ or US-6316349-\$ or US-6368979-\$ or US-6368979-\$ or US-6387775-\$ or US-6387775-\$ or US-6410437-\$ or US-6410437-\$ or US-6451673-\$ or US-6455411-\$ or US-6472317-\$ or US-64506680-\$ or US-6506680-\$ or US-66903042-\$ or US-66903042-\$ or US-66903042-\$ or US-66743732-\$ or US-66743732-\$ or US-66743732-\$ or US-667630674-\$).did. or	US-PGPU B; USPAT; DERWEN T	OR	OFF	2005/09/23 17:57
L6	24	(US-6472317-\$).did. (C5F8 "C.sub.5 F.sub.8")	US-PGPU	OR	ON	2005/09/23
		same (N2 "N.sub.2" nitrogen) same (ar argon) same etch\$3 not 3	B; USPAT			16:35

L5	0	(C5F8 "C.sub.5 F.sub.8") with (N2 "N.sub.2" nitrogen) same (ar argon) same etch\$3 not 3	US-PGPU B; USPAT	OR	ON	2005/09/23 16:35
L3	14	(C5F8 "C.sub.5 F.sub.8") with (N2 "N.sub.2" nitrogen) with (ar argon) same etch\$3	US-PGPU B; USPAT	OR	ON	2005/09/23 16:34
L4	5	3 not 2	US-PGPU B; USPAT	OR	ON	2005/09/23 16:33
L2	9	(C5F8 "C.sub.5 F.sub.8") with (N2 "N.sub.2" nitrogen) with (ar argon) with etch\$3	US-PGPU B; USPAT	OR	ON	2005/09/23 16:33
L1	17148	(C5F8 "C.sub.5 F.sub.8") same (N2 "N.sub.2" nitrogen) (ar argon) same etch\$3	US-PGPU B; USPAT	OR	ON	2005/09/23 16:31
S63	24	((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane) same (CH2F2 CF2H2 "CH.sub.2 F.sub.2" "CF.sub.2 H.sub. 2" difluoromethane) same (N2 "N.sub.2" nitrogen)) same etch\$3 not (S60 S61)	US-PGPU B; USPAT	OR	ON	2005/09/23 16:29
S60	13	((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane) with (CH2F2 CF2H2 "CH.sub.2 F.sub.2" "CF.sub.2 H.sub. 2" difluoromethane) with (N2 "N.sub.2" nitrogen)) with etch\$3	US-PGPU B; USPAT	OR	ON	2005/09/23 02:54
S62	3	("6121145" "6211092" "6251789").PN. OR ("6506680").URPN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/09/23 02:50

S61	5	((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane) with (CH2F2 CF2H2 "CH.sub.2 F.sub.2" "CF.sub.2 H.sub. 2" difluoromethane) with (N2 "N.sub.2" nitrogen)) same etch\$3 not S60	US-PGPU B; USPAT	OR	ON	2005/09/23 02:47
S56	0	S52 and ((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane) with (CH2F2 CF2H2 "CH.sub.2 F.sub.2" "CF.sub.2 H.sub. 2" difluoromethane) with (N2 "N.sub.2" nitrogen))	US-PGPU B; USPAT	OR	ON	2005/09/23 02:42
S58	14	S55 S57	US-PGPU B; USPAT	OR	ON	2005/09/23 01:02
S57	5	S52 and ((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane C4F6 "C. sub.4 F.sub.6" perfluorobutadiene octafluorobutadiene C5F8 "C.sub.5 F.sub.8") with (N2 "N.sub.2" nitrogen))	US-PGPU B; USPAT	OR	ON	2005/09/23 01:02
S53	5	S49 and ((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane C4F6 "C. sub.4 F.sub.6" perfluorobutadiene octafluorobutadiene C5F8 "C.sub.5 F.sub.8") with (N2 "N.sub.2" nitrogen))	US-PGPU B; USPAT	OR	ON	2005/09/23 01:02

S55	11	S52 and (((oxygen adj free oxygen-free "without oxygen" "no oxygen") (O2 adj free O2-free "without O2" "no O2") ("O.sub.2" adj free "O.sub.2-free" "without O.sub.2" "no O. sub.2") ("0.sub.2" adj free "0.sub.2-free" "without O. sub.2") ("02" adj free 02-free "without O2" "no 02")) (dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3)	US-PGPU B; USPAT	OR	ON	2005/09/23 01:01
S51	1	S49 and ((C4F8 "C.sub.4 F.sub.8" perfluorobutane octafluorobutane) with (CH2F2 CF2H2 "CH.sub.2 F.sub.2" "CF.sub.2 H.sub. 2" difluoromethane) with (N2 "N.sub.2" nitrogen))	US-PGPU B; USPAT	OR	ON	2005/09/23 01:01
S50	18	S49 and (((oxygen adj free oxygen-free "without oxygen" "no oxygen") (O2 adj free O2-free "without O2" "no O2") ("O.sub.2" adj free "O.sub.2-free" "without O.sub.2" "no O. sub.2") ("0.sub.2" adj free "0.sub.2-free" "without O. sub.2") ("02" adj free 02-free "without 0. sub.2" "no 02")) (dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3)	US-PGPU B; USPAT	OR	ON	2005/09/23 01:01

S54	3	S49 and S52	US-PGPU B; USPAT	OR	ON	2005/09/23 00:59
S52	67	("4654112" "5021121" "5234537" "5269879" "5272115" "5290383" "5302236" "5302240" "5308742" "5322590" "5338399" "5356515" "5445710" "5514247"). PN. OR ("5843847"). URPN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/09/23 00:52
S47	12	S46 and ((oxygen adj free oxygen-free "without oxygen" "no oxygen") (O2 adj free O2-free "without O2" "no O2") ("O.sub.2" adj free "O.sub.2-free" "without O.sub.2" "no O. sub.2") ("0.sub.2" adj free "0.sub.2-free" "without 0. sub.2" "no 0.sub.2") ("02" adj free 02-free "without 02" "no 02"))	US-PGPU B; USPAT	OR	ON	2005/09/23 00:46
S49	89	("4407850" "4473436" "4617079" "4784720" "4844773" "4908333" "4948459" "4948462" "4973381" "4978420" "4981550" "5006485" "5022958").PN. OR ("5269879").URPN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/09/22 23:45
S48	1	("5269879").PN.	USPAT	OR	OFF	2005/09/22 23:45

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S46	162	("20010008226"	US-PGPU	OR	OFF	2005/09/22
		"20020038910"	B;			21:11
		"4349609" "4654112"	USPAT; USOCR			
		"5021121" "5234537" "5242707" "5262279"	USUCK			
		"5269879" "5272115"				
		"5290383" "5302236"				
		"5302240" "5308742"				
		"5322590" "5338399"	•			
1		"5356515" "5 44 5710"				
		"5468342" "5514247"				
		"5562801" "5679608"				
		"5698339" "5783363"				
		"5877080" "5911887"				
		"6016012" "6074959"				
		"6114250" "6127070"				
		"6180540" "6204070"				
		"6204168" "6204192"				
		"6207493" "6211035" "6344003" "6334773"				
		"6211092" "6221772"				
		"6228774" "6232237" "6384140" "6316351"				
		"6284149" "6316351" "6226206" "6372634"				
		"6326296" "6372634" "6475922").PN. OR				
		("2003/0045101"				
		"2003/0043101" "2003/0162407"				
		"5843847" "6284149"				
		"6455411" "6485988"				
		"6670276" "6693042").				
		URPN.				
CAE	4:	CAT HEL CAD	HC DCDH	OD	ONI	2005/05/05
S45	15	S41 not S42	US-PGPU	OR	ON	2005/05/05
			B;			13:36
			USPAT; EPO;			
			JPO;			
			DERWEN			
			T;			
			IBM_TDB			
644	4.0	C42 C42		00	011	2005/05/05
S44	18	S42 not S43	US-PGPU	OR	ON	2005/05/05
			B; USPAT;			13:35
			EPO;			
i			JPO;			
			DERWEN			
			T;			
			IBM_TDB			
				L		

S43	14	(low adj k adj dielectric low-k-dielectric low-k adj dielectric ((low adj k low-k) adj material)) with etch\$3 same (nitrogen N2 "N.sub.2") with (C4F6 C5F8 C4F8 C6F6 "C.sub.4 F.sub.6" "C.sub.5 F.sub.8" "C.sub.4 F.sub.6" "C.sub.6 F.sub.6")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2005/05/05 13:16
542	32	(low adj k adj dielectric low-k-dielectric low-k adj dielectric ((low adj k low-k) adj material)) with etch\$3 and (nitrogen N2 "N.sub.2") with (C4F6 C5F8 C4F8 C6F6 "C.sub.4 F.sub.6" "C.sub.5 F.sub.8" "C.sub.6 F.sub.6")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2005/05/05 13:07
S41	47	(low adj k adj dielectric low-k-dielectric low-k adj dielectric ((low adj k low-k) adj material)) and etch\$3 and (nitrogen N2 "N.sub.2") with (C4F6 C5F8 C4F8 C6F6 "C.sub.4 F.sub.6" "C.sub.5 F.sub.8" "C.sub.4 F.sub.6")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2005/05/05 13:07
S1	288	(low adj k adj dielectric low-k-dielectric low-k adj dielectric ((low adj k low-k) adj material)) and (etch\$3 plasma) and (nitrogen N2 "n.sub.2") and (fluorocarbon hydrofluorocarbon C4F6 C5F8 C4F8 CF2H2 CH2F2 "C.sub.4 F.sub.6" "C.sub.5 F.sub.8" "CF.sub.2 H.sub.2" "CH. sub.2 F.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2005/05/05 13:04
S40	1	("6403491").PN.	USPAT; USOCR	OR	OFF	2004/09/30 00:02

S39	1	(multiple dual) near frequency same mxp	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	OFF	2004/09/30 00:01
538	0	(multiple dual) near frequency with mxp	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	OFF	2004/09/29 23:59
S37	11	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3 same (C4F8 "C.sub.4 F.sub.8") with (CH2F2 "CH.sub.2 F. sub.2" CF2H2 "CF.sub.2 H.sub.2") and (nitrogen N2 "N.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 03:05
S36	28	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3 and (C4F8 "C.sub.4 F.sub.8") and (CH2F2 "CH.sub.2 F.sub. 2" CF2H2 "CF.sub.2 H. sub.2") and (nitrogen N2 "N.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 03:05

S19	4238	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 02:53
S35	66	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) same (low-k low adj (dielectric k)) and etch\$3 same (selectiv\$3 with (mask\$3 overlying)) same (nitrogen N2 "N.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:35
S34	3	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) same (low-k low adj (dielectric k)) same etch\$3 same (selectiv\$3 with (mask\$3 overlying)) same (nitrogen N2 "N.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:33
S33	415	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:32

S32	20	(((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3) and Lam. as.) not ((((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")) and Lam.as.) (((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3) and Lam.as.) (((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) same (low-k low adj (dielectric k)) same etch\$3) and Lam.as.))	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:23
S31	38	((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) and (low-k low adj (dielectric k)) and etch\$3) and Lam. as.	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:23

S27	11	((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3) and Lam. as.	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:23
S30	7	(((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) same (low-k low adj (dielectric k)) same etch\$3) and Lam.as.) not (((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3) and Lam.as.) (((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")) and Lam.as.))	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:17
S29	18	((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) same (low-k low adj (dielectric k)) same etch\$3) and Lam.as.	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:16

S28	7	(((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3) and Lam. as.) not (((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")) and Lam.as.)	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:16
S25	4	((dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")) and Lam. as.	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/10 00:09

S26	21	((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying))) not (((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")) ((dop\$3 with ((silicon adj \$2oxide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$2oxide FSG CORAL HOSP HSQ) near2 (low-k low adj (dielectric k)) near2 etch\$3))	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/09 22:02
S24	29	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying)) and (nitrogen N2 "N.sub.2")	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/09 21:57

S23	51	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3 and (selectiv\$3 with (mask\$3 overlying))	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/09 21:48
S21	233	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) with (low-k low adj (dielectric k)) with etch\$3	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/09 21:46
S22	7	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) near2 (low-k low adj (dielectric k)) near2 etch\$3	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/09 21:33
S20	981	(dop\$3 with ((silicon adj \$20xide) oxide silicate glass) BPSG PSG (fluorinated fluoro) adj silicon adj \$20xide FSG CORAL HOSP HSQ) same (low-k low adj (dielectric k)) same etch\$3	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2004/09/09 21:31